

**Search Notes**

Application/Control No.

10/560,281

Examiner

Karen Cheng

Applicant(s)/Patent under  
Reexamination

TACHIBANA ET AL.

Art Unit

1626

**SEARCHED**

Class	Subclass	Date	Examiner
548	301.7	1/6/2007	KC
548	318.5	1/6/2007	KC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN Structure Search (see attached)	1/5/2007	KC
Inventor Name Search	1/5/2007	KC
EAST Search (see attached)	1/6/2007	KC